

<b>Search Notes</b>  <b>*1077457</b>  <b>7*</b>	<b>Application/Control No.</b>  10774577	<b>Applicant(s)/Patent Under Reexamination</b>  COGGAN ET AL.
	<b>Examiner</b>  Dawn Garrett	<b>Art Unit</b>  1786

SEARCHED			
Class	Subclass	Date	Examiner
428	690, 917 (limited by text searching for all listed, see EAST search printout)	6-5-08	DG
313	504, 506	6-5-08	DG
	see EAST search history printout(s) in application file		DG

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search updated	6-5-08	DG
STIC structure search by EIC 1700 (see printout attached)	5-2008	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	6-5-08	DG
See all search notes pages in application file		
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-3-08	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	6-1-2009, 6-4-2009	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-2-2009	DG
Reviewed STIC structure searches in application file	12-2-2009	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	7-1-2010	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-16-2010	DG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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